## Application/Control No. Applicant(s)/Patent Under Reexamination 10/601,643 HATANO ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2629 Seokyun Moon **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY 257/72 US-7,173,282 02-2007 Yamazaki et al. Α \* 349/33 US-6,490,013 12-2002 Koma, Norio В US-С US-D US-Ε US-F US-G US-Н US-US-J US-Κ US-US-М FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) Ų

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